

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination FUTAGAWA ET AL.	
	Examiner Christopher P Bruenjes	Art Unit 1772	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,387,449	02-1995	Kunz et al.	428/35.4
	C	US-5,391,423	02-1995	Wnuk et al.	428/217
	D	US-6,146,726	11-2000	Yoshii et al.	428/35.9
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	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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